

<b>Notice of References Cited</b>	Application/Control No. 10/823,063		Applicant(s)/Patent Under Reexamination FAN ET AL.	
	Examiner Biju Chandran		Art Unit 2835	Page 1 of 1

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*	B	US-5,638,258	06-1997	Lin, Jen-Cheng	361/704
*	C	US-2003/0218866 A1	11-2003	Chen et al.	361/704
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	M	US-			

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**NON-PATENT DOCUMENTS**

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